## Notice of References Cited

Application/Control No. 09/986,333		Applicant(s)/Patent Under Reexamination CHEN ET AL.		
Examiner	Art Unit			
TUAN A PHAM	2643	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-2003/0026247	02-2003	Bernstein, Jeffrey G.	370/352
	В	US-5,812,646	09-1998	Kikuchi, Akio	379/100.16
	С	US-2003/0083009	05-2003	Freyman et al.	455/26.1
	D	US-6,002,747	12-1999	Eftechiou, Vakis	379/35
	Ε	US-2002/0196777	12-2002	Wu et al.	370/352
	F	US-6868081	03-2005	Akram et al.	370/356
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-	-		
	L	US-		-	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	O					
	R			, , , , , , , , , , , , , , , , , , , ,		
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	,
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.